Search Notes					
	 				
	8 W aaa iika ii aaa iii a i auu i aa :				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/723,135	
Examiner	Art Unit
David E. Martinez	2181

SEARCHED				
Class	Subclass	Date	Examiner	
-				
		-		
		,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		·		
			<u> </u>	

SEARCH NOT (INCLUDING SEARCH)
·	DATE	EXMR
East see attached	12/31/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	12/31/2006	DM
Inventor search eDan	12/31/2006	DM
710/52,29,33.ccls. 714/776.ccls. 709/231,232.ccls. 370/395.1,395.52.ccls. with keywords and text search	12/31/2006	DM
	÷	
-		